

Search Notes

Application/Control No.

10/668,707

Examiner

Tai Van Nguyen

Applicant(s)/Patent under
Reexamination

BANDIC ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	603.03	3/8/2006	TN
	603.01		
	603.09		
360	133, 129	3/8/2006	TN
	266.4		
	251.5		
	291		
361	679, 680		
	683		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Dexter Tubang Primary class: 29	3/8/2006	TN
Consulted with Craig Renner Primary class: 360	3/8/2006	TN
East Search	3/10/2006	TN